

Notice of References Cited	Application/Control No. 10/670,253	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Kimnhung Nguyen	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,608,625	08-2003	Chin et al.	345/501
*	B	US-2004/0148307	07-2004	Rempell, Steven H.	707/102
*	C	US-2004/0046772	03-2004	Ouchi et al.	345/690
*	D	US-6,661,422	12-2003	Valmiki et al.	345/530
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	I	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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